Poster:

Charge Resolution Study on AMS-02 Silicon Layer 0 Prototype



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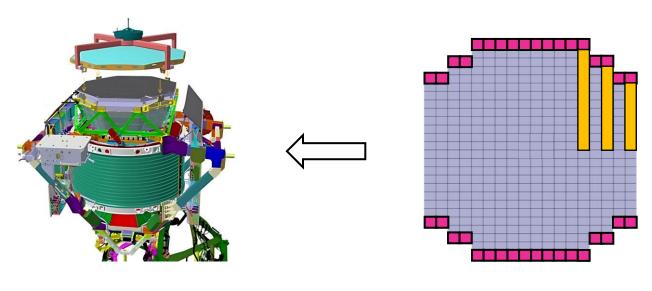
ASAPP 2023





Layer 0 (L0) upgrade

 By the end of 2024 AMS-02 will be subject to the Layer 0 upgrade that will add a layer of silicon tracker (L0) on top of the detector. The layer will be composed by two planes of silicon micro-strips sensors that will be arranged in mechanicalelectrical units called «ladders»;

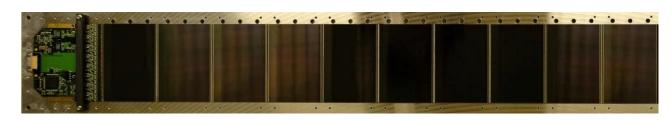


+ Silicon ladders of the upgrade

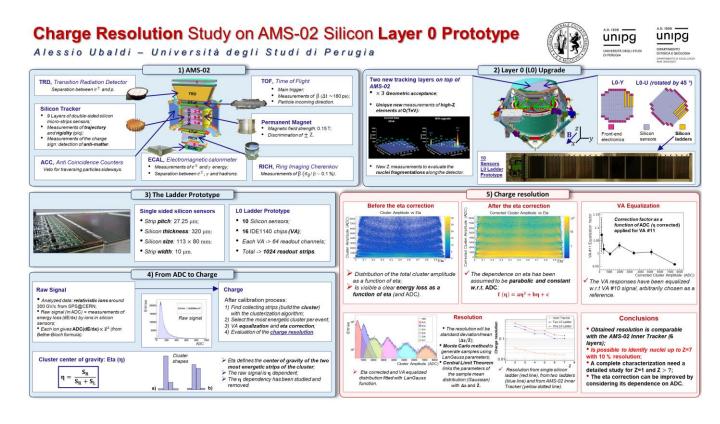


Layer 0 ladder prototype

- A 10 silicon sensors ladder prototype has been exposed to ions beam at CERN;
- The goal of my study was to evaluate the charge resolution of this ladder.



The poster



The content

- The AMS-02 experiment
- The Layer 0 upgrade
- The ladder prototype
- The procedure to analyze the signal
- The method to evaluate the charge resolution
- Comparison with the current AMS-02 resolution
- Conclusions

Fine

Thank you for your attention.